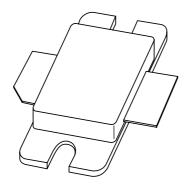
## **DISCRETE SEMICONDUCTORS**

# DATA SHEET



# **BLF2022-125**UHF power LDMOS transistor

Objective specification Supersedes data of 2002 April 02 2003 Mar 07





### **UHF power LDMOS transistor**

#### BLF2022-125

#### **FEATURES**

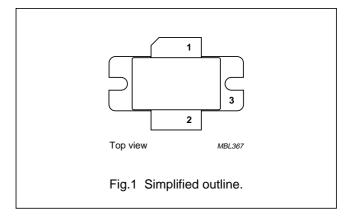
- Typical W-CDMA performance at a supply voltage of 28 V and I<sub>DQ</sub> of 1 A
  - Output power = 20 W (AV)
  - Gain = 12 dB
  - Efficiency = 19%
  - ACPR = -42 dBc at 3.84 MHz
- · Easy power control
- · Excellent ruggedness
- · High power gain
- · Excellent thermal stability
- Designed for broadband operation (2000 to 2200 MHz)
- · Internally matched for ease of use.

#### **APPLICATIONS**

 RF power amplifiers for W-CDMA base stations and multicarrier applications in the 2000 to 2200 MHz frequency range

#### **PINNING - SOT634A**

PIN	DESCRIPTION				
1	drain				
2	gate				
3	source, connected to flange				



#### **DESCRIPTION**

125 W LDMOS power transistor for base station applications at frequencies from 2000 to 2200 MHz.

#### **QUICK REFERENCE DATA**

RF performance at  $T_h = 25$  °C in a common source test circuit; single-carrier W-CDMA test model 1, 64 channels, 3.84 MHz channel bandwidth; Peak/Average = 9.8 dB at 0.01% probability on CCDF.

MODE OF OPERATION	OF OPERATION f (MHz)		P <sub>L avg</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	d <sub>im</sub> (dBc)
single carrier W-CDMA	2110 to 2170	28	30	typ 12	typ 19	typ -42

#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage	_	65	V
$V_{GS}$	gate-source voltage	_	±15	V
I <sub>D</sub>	drain current (DC)	_	tbd	А
T <sub>stg</sub>	storage temperature	-65	+150	°C
Tj	junction temperature	_	200	°C

#### **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

# UHF power LDMOS transistor

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#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-c</sub>	thermal resistance from junction to case	note 1	0.55	K/W

#### Note

1. Thermal resistance is determined under specified RF operating conditions.

#### **CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0$ ; $I_D = 2.5 \text{ mA}$	65	_	_	V
$V_{GSth}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 240 \text{ mA}$	4.5	_	5.5	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 26 V	_	_	10	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0$	_	_	40	nA
9 <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 16 A	_	9.5	_	S
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = V_{GSth} + 9 \text{ V}; I_D = 8 \text{ A}$	_	0.07	_	Ω
C <sub>rss</sub>	feedback capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 26 V; f = 1 MHz	_	tbd	_	pF

# **UHF** power LDMOS transistor

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#### **APPLICATION INFORMATION**

RF performance at  $T_h$  = 25 °C in a common source test circuit; single-carrier W-CDMA test model 1, 64 channels, with 68% clipping, 3.84 MHz channel bandwidth; Peak/Average = 8.5 dB at 0.01% probability on CCDF.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
G <sub>p</sub>	common-source power gain	$V_D$ = 28 V; $P_{out}$ = 20 W (AV), single carrier W-CDMA; $I_{DQ}$ = 1000 mA; $f$ = 2.11 to 2.17 GHz	11	12	_	dB
η <sub>D</sub>	drain efficiency	$V_D$ = 28 V; $P_{out}$ = 20 W (AV), single carrier W-CDMA; $I_{DQ}$ = 1000 mA; $f$ = 2.11 to 2.17 GHz	17	19	_	%
ACPR	adjacent channel power ratio	$V_D$ = 28 V; $P_{out}$ = 20 W (AV), single carrier W-CDMA; $I_{DQ}$ = 1000 mA; $f$ = 2.11 to 2.17 GHz	_	-49	-39	dBc
I <sub>RL</sub>	input return loss	$V_D$ = 28 V; $P_{out}$ = 20 W (AV), single carrier W-CDMA; $I_{DQ}$ = 1000 mA; $f$ = 2.11 to 2.17 GHz	_	-10	-6	dB
Ψ	output mismatch	V <sub>D</sub> = 28 V; P <sub>out</sub> = 20 W (AV) single carrier W-CDMA;VSWR = 5:1 through all phases	1	radation nance be	in RF fore and	after

RF performance at  $T_h$  = 25 °C in a common source test circuit; two-carrier W-CDMA signals, 3GPP test mode 1 64 channels, with 68% clipping, 3.84 MHz channel bandwidth; Peak/Average = 8.5 dB at 0.01% probability on CCDF per channel frequency range is 2.11 GHz to 2.17 GHz; carrier spacing is 10 MHz.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
G <sub>p</sub>	common-source power gain	$V_D = 28 \text{ V}; P_{out} = 20 \text{ W (AV)};$ $I_{DQ} = 1000 \text{ mA}$	_	12	_	dB
$\eta_{D}$	drain efficiency	$V_D = 28 \text{ V}; P_{out} = 20 \text{ W (AV)};$ $I_{DQ} = 1000 \text{ mA}$	_	19	_	%
ACPR	adjacent channel power ratio	$V_D$ = 28 V; $P_{out}$ = 20 W (AV); $I_{DQ}$ = 1000 mA; ACPR is measured at $f_1$ = -5 MHz and $f_2$ = +5 MHz	_	-40	_	dBc
d <sub>3</sub>	third order intermodulation distortion	$V_D = 28 \text{ V}; P_{out} = 20 \text{ W (AV)};$ $I_{DQ} = 1000 \text{ mA}; ACPR \text{ is measured at}$ $f_1 = -10 \text{ MHz} \text{ and } f_2 = +10 \text{ MHz}$	-	-36	-	dB
I <sub>RL</sub>	input return loss	$V_D = 28 \text{ V}; P_{out} = 20 \text{ W (AV)};$ $I_{DQ} = 1000 \text{ mA}$	_	-10	_	dB

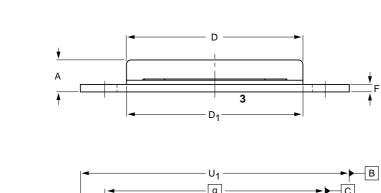
# UHF power LDMOS transistor

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#### **PACKAGE OUTLINE**

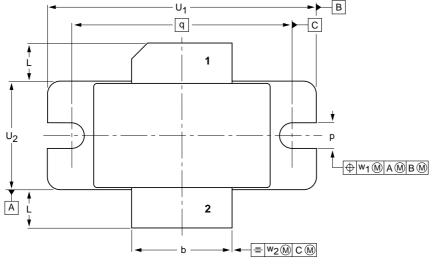
Flanged ceramic package; 2 mounting holes; 2 leads

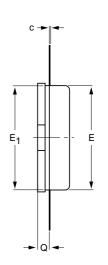
**SOT634A** 





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0 5 10 mm scale

#### DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	U	D	D <sub>1</sub>	Е	E <sub>1</sub>	F	L	р	ø	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>
mm	4.83 3.68	12.82 12.57	0.15 0.08	22.58 22.12	22.56 22.15		13.34 13.08	1.14 0.89	5.33 4.32	3.38 3.12	1.70 1.45	27.94	34.16 33.91	13.84 13.59	0.25	0.51
inches	0.190 0.145	0.505 0.495	0.006 0.003	0.889 0.871	0.888 0.872		0.525 0.515	0.045 0.035	0.210 0.170	0.133 0.123	0.067 0.057	1.100	1.345 1.335	0.545 0.535	0.010	0.020

OUTLINE		REFER	EUROPEAN ISSUE DA			
VERSION	IEC	JEDEC EIAJ PROJECT		PROJECTION	ISSUE DATE	
SOT634A						01-11-27

#### **UHF** power LDMOS transistor

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#### **DATA SHEET STATUS**

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS(2)(3)	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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- 2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

#### **DEFINITIONS**

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